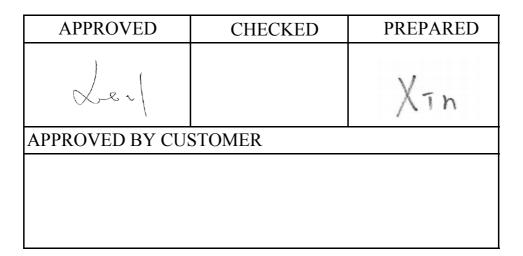
# APPROVAL SHEET

| Customer Name    | :  |                 |       |
|------------------|----|-----------------|-------|
| Customer P/N     | :  |                 |       |
| Frequency        | :  | 27.000000       | MHz   |
| Aker Approved P/ | N: | CXAN-027000-3-D | 4-05  |
| Aker MPN         | :  | CXAN-027000-3-D | 94-05 |
| Rev.             | •  | 1               |       |
| ISSUE DATE       | :  | Feb.9.2023      |       |



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MSL:Level 1 RoHS compliant

|                         | Aker Ap |
|-------------------------|---------|
|                         | APPRO   |
|                         | PREPAI  |
| Accurate Kinetic Energy |         |

| Aker Approved P/N | • | CXAN-027000-3-D4-05 |                |  |
|-------------------|---|---------------------|----------------|--|
| APPROVED          | : | Xtal                | SHEET : 1 of 9 |  |
| PREPARED          | • | Xin                 | REV. : 1       |  |
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| Rev. | Date     | Reviser | Revise contents  |
|------|----------|---------|------------------|
| 1    | 2023/2/9 | Xin     | Initial Released |
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| APPROVED          | : | Xtal                | SHEET : 2 of 9 |  |  |  |
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## **SMD CRYSTAL SPECIFICATION**

## **1. ELECTRICAL CHARACTERISTICS**

■ Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow :

Ambient temperature : 25±5 ℃

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature :  $25\pm3$  °C

Relative humidity : 40%~70%

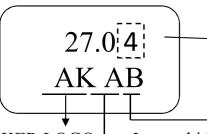
- AKER Model : CXA-321
- Oscillation Mode : Fundamental
- Cutting Mode : AT CUT
- Measurement Equipment : 250B(Measured FL)
- Insulation Resistance : More than 500M ohms at DC 100V

|                                  |  | Electrical Spec |         |      |        |                                 |  |
|----------------------------------|--|-----------------|---------|------|--------|---------------------------------|--|
| Parameters                       | Symbol   | Min.            | Тур.    | Max. | Units. | Notes                           |  |
| Nominal Frequency                | FL   | 2               | 7.00000 | 0    | MHz    |                                 |  |
| Frequency Tolerance              |  |                 | ±20     |      | ppm    | at $25^{\circ}C \pm 3^{\circ}C$ |  |
| Frequency Stability              |  |                 | ±20     |      | ppm    | Operating Temp (Refer 25°C)     |  |
| Load Capacitance                 | CL   |                 | 20      |      | pF     |                                 |  |
| Aging                            |  |                 | ±3      |      | ppm    | First Year                      |  |
| Operating Temperature            |  | -40             | $\sim$  | 85   | °C     |                                 |  |
| Storage Temperature Range        |  | -55             | $\sim$  | 125  | °C     |                                 |  |
| Drive Level                      | DL   |                 |         | 100  | uW     |                                 |  |
| Equivalent Series Resistance     | ESR  |                 |         | 40   | Ω      | @Series                         |  |
| Shunt Capacitance                | C0   |                 |         | 5    | pF     |                                 |  |
| *Please kindly be noted that AKE | *Please kindly be noted that AKER DO NOT guarantee parts quality which involves human security application.* |                 |         |      |        |                                 |  |



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### 2. MARKING :



FREQUENCY code & Internal identification code 1

AKER LOGO. Internal identification code 2

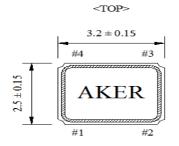
#### Date Code Table

|                           | Month<br>Year |        | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 |
|---------------------------|---------------|--------|---|---|---|---|---|---|---|---|---|----|----|----|
| 2019                      | 2023          | (4N+3) | Α | В | С | D | E | F | G | Н | J | Κ  | L  | М  |
| 2020                      | 2024          | (4N+0) | Ν | Р | Q | R | S | Т | U | V | W | Х  | Y  | Ζ  |
| 2021                      | 2025          | (4N+1) | а | b | С | d | е | f | g | h | j | k  |    | m  |
| 2022                      | 2026          | (4N+2) | n | р | q | r | S | t | u | V | W | Х  | У  | Z  |
| A syste system four years |               |        |   |   |   |   |   |   |   |   |   |    |    |    |

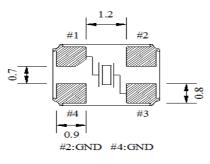
A cycle every four years

## **3**. DIMENSION :

(Unit:mm)





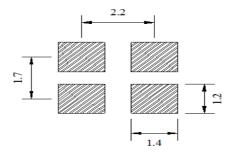




<SIDE>



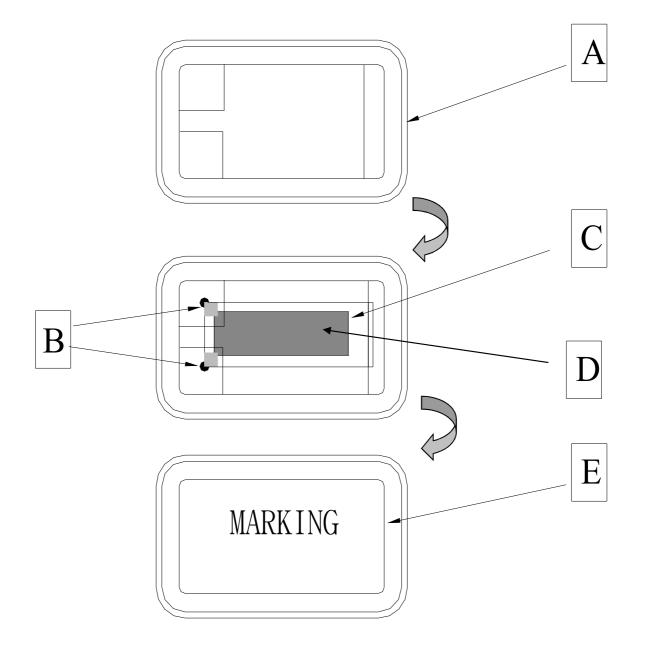
<SUGGESTED LAYOUT>



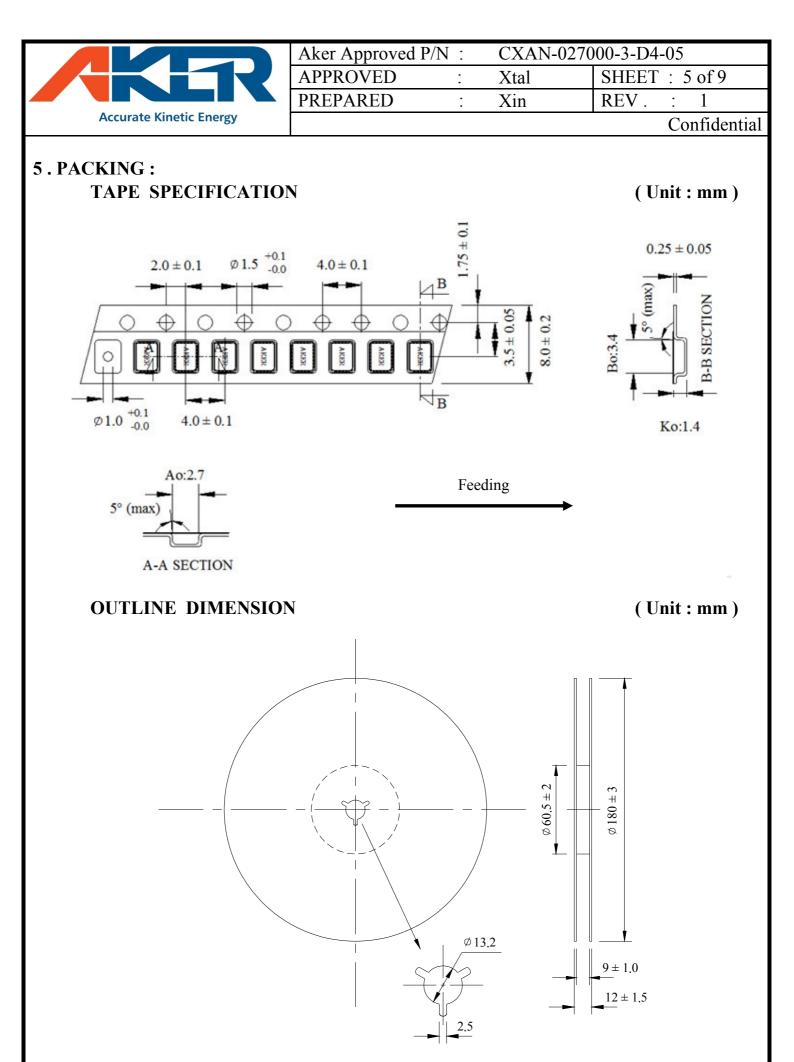


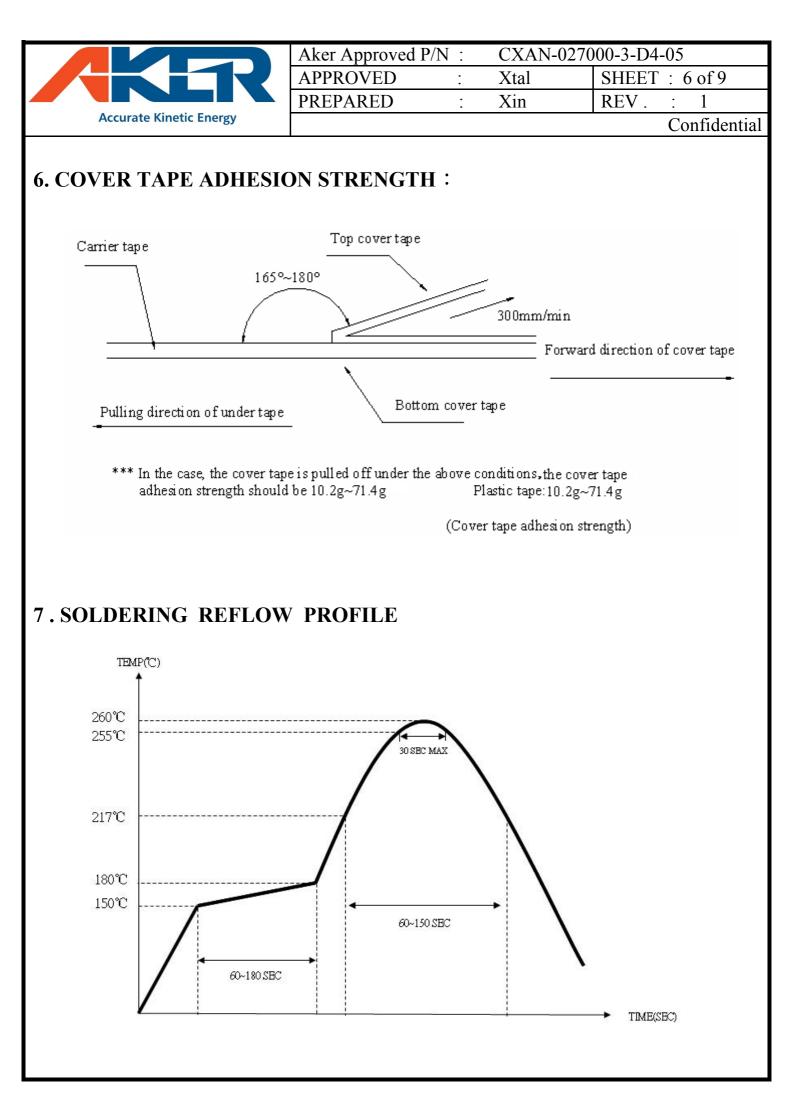
| Aker Approved P/N : | CXAN-027 | CXAN-027000-3-D4-05 |  |  |  |  |
|---------------------|----------|---------------------|--|--|--|--|
| APPROVED :          | Xtal     | SHEET : 4 of 9      |  |  |  |  |
| PREPARED :          | Xin      | REV. : 1            |  |  |  |  |
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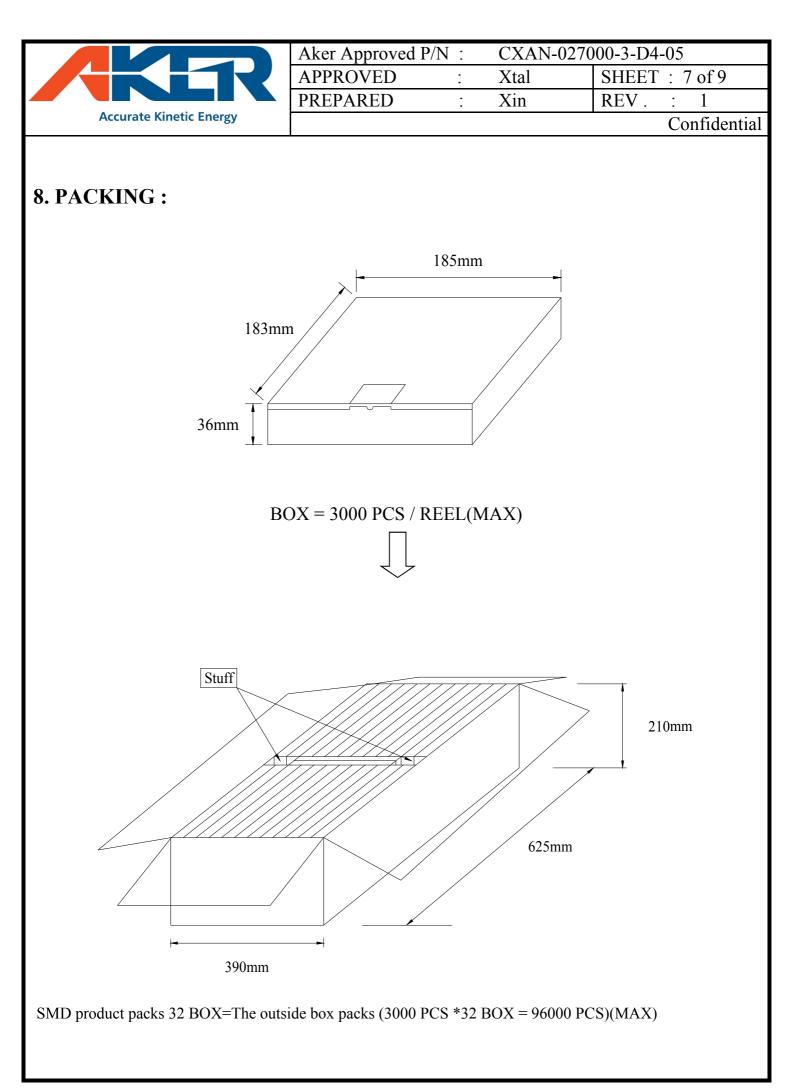
## 4. STRUCTURE ILLUSTRATION



|   | COMPONENTS          | MATERIALS                      | CO | MPONENTS  | MATERIALS |
|---|---------------------|--------------------------------|----|-----------|-----------|
| Α | Base (Package)      | Ceramic(Al2O3)+Kovar(Fe/Co/Ni) | D  | Electrode | Cr / Ag   |
| В | Conductive adhesive | Ag / Silicon resin             | E  | Lid       | Fe/Co/Ni  |
| С | Crystal blank       | SiO2                           |    |           |           |









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## 9. MECHANICAL PERFORMANCE

| 7. MECHAN          | ICAL PERFORMANCE  | Т                                       |
|--------------------|---|---|
| TEST ITEMS         | TEST METHODS AND TEST CONDITION   | PERFORMANCE                             |
| 9.1 Drop Test      | The specimen is measured for its frequency and<br>resistance before the test. It is then dropped from<br>a hight of 75 cm or more as a free fall object onto<br>a hard wooden plate of 30mm or more in thickness.<br>( in accordance with JIS-C0044 )   |   |
| 9.2 Vibration Test | The specimen is measured for its frequency<br>and resistance before the test. Most them into<br>X,Y and Z axes, respectively, for the vibration test.<br>Vibration condition:<br>Frequency range ; 20 $\sim$ 2000HZ<br>Peak to peak amplitude : 1.52 mm<br>Peak acceleration : 20G<br>Sweep time : 20 minute / axis<br>Pendicular total test time : 4 hours | To satisfy the electrical performance . |
| 9.3 Resistance to  | ( in accordance with MIL-STD-883F : 2007.3 )<br>The specimen is measured for its frequency and  | -                                       |
| Soldering Test     | resistance before the test. Place the specimen on   |   |
| Soldering rest     | the belt of the converynace and let it pass through   |   |
|                    | the reflow with the presetted temperature condition.  |   |
|                    | After passing twice the reflow place, the specimen  |   |
|                    | under the referee condition for $-2$ hours and then   |   |
|                    | measure its electrical performance.   |   |
|                    | Temperature Condition of IR Simulation:   |   |
|                    | The temperature range of the preheated section<br>is setted at $150 \sim 180$ °C for $60 \sim 120$ sec. For the next  |   |
|                    | section the temperature range is setted at $217 \sim 260^{\circ}$ C   |   |
|                    | for $45 \sim 90$ sec. and within this time range the specimen   |   |
|                    | should be able to sustain at the peak temperature,  |   |
|                    | $260+/-3^{\circ}$ C , for 10 sec long.  |   |
|                    | ( in accordance with JESD22-B106-B )  |   |
| 9.4 Fine Leak      | Place the specimen in a pressurized container and   |   |
| Test               | pressurize it with the detection gas (mixed gas   | Less than                               |
|                    | consisting of 95% or more helium ) for at least 2 hours.  | $1.0 * 10^{-8}$ atm .c.c. / sec,        |
|                    | Complete the measurement of the concentration of  | Helium                                  |
|                    | helium within 30 min after taking it out from the   |   |
|                    | pressurized container.  |   |
|                    | ( in accordance with MIL-STD-883F: 1014.11 )  |   |
|                    | The referee condition.  | •                                       |
|                    | Temperature $25 \pm 2$ °C   |   |
|                    | Humidity $44 \sim 55\%$   |   |
|                    | Pressure 86 ~ 106 kPa   |   |
|                    | ( in accordance with MIL-STD-883E: 1014.9)  |   |



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## **10. CLIMATIC RESISTANCE**

|  |   | Г                         |
|--|---|---------------------------|
| TEST ITEMS                                 | TEST METHODS AND TEST CONDITION   | PERFORMANCE               |
| 10.1 Low Temp<br>Exposure Test             | The specimen is measured for its frequency and<br>resistance before the test .<br>Place the specimen in the chamber and kept it<br>at the temperature of $-40 \pm 3^{\circ}$ C for $168 \pm 6$ hours .<br>Take the specimen out of the chamber<br>and measure itselectrical performance after<br>leaving 1 ~ 2 hours under the referee condition.<br>( in accordance with JIS-C0020 )   |                           |
| 10.2 Aging Test                            | The specimen is measured for its frequency and<br>resistance before the test .<br>Place the specimen in the testing chamber and keep it<br>at the temperature of $+125 \pm 3^{\circ}$ C for $720 \pm 48$ hours.<br>And then take the specimen out of the chamber and  | To satisfy the electrical |
|  | <pre>measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition . ( in accordance with JIS-C0021 )</pre>  | performance .             |
| 10.3 High<br>Temperature &<br>High Humidty | The specimen is measured for its frequency<br>and resistance before the test .<br>Place the specimen in the testing chamber and<br>kept it at the temperature of $+85 \pm 5$ °C and<br>humidity of $85 \pm 5$ % for $168 \pm 6$ hours.and<br>then take the specimen out and measure its<br>electrical performance after leaving for 1 ~ 2<br>hours under the referee condition.<br>( in accordance with MIL-STD-883F : 1004.7 )                               |                           |
| 10.4 Temperature<br>Cycle Test             | The specimen is measured for its frequency<br>and resistance before the test .<br>Subject the specimen to the 100 cycles of<br>temperature ranges stated below .<br>High temp . + $125 \pm 3 \degree C$ ( $15\pm 3 \min$ ).<br>$2 \sim 3 \min$ .<br>Low temp $55 \pm 3 \degree C$ ( $15\pm 3 \min$ ).<br>Measure its electrical performance after leaving it<br>for 1 ~ 2 hours under the referee condition .<br>( in accordance with MIL-STD-883F : 1010.8 ) |                           |